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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

100725-00113

APPLICANT

KURA et al.

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(Use several sheets if necessary)

Herewith 1/28/04 GROUP 3679

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EXAMINER	Greg Binda Patent Exeminer	DATE CONSIDERED 2 1 SEP 2004
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*EXAMINER:

Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.